

Contents

Part I. Experimental Realization

1. Basic Elements of the Equipment	3
1.1 X-Ray Sources	3
1.2 Monochromators and Collimators	6
1.3 Detectors	12
2. Diffractometers and Reflectometers	17
2.1 X-Ray Reflectometers	18
2.2 High-Resolution Diffractometer	21
2.3 Limits on the Use of Powder Diffractometers	23
2.4 Grazing-Incidence Diffraction	24
3. Scans and Resolution	
in Angular and Reciprocal Space	27
3.1 Coherence of Radiation at the Sample Position	28
3.2 Scans Across Reciprocal Space	30
3.3 Resolution Elements in Reciprocal Space	33
References: Part I	39

Part II. Theory

4. Basic Principles	43
4.1 Description of the X-Ray Wavefield	43
4.2 Translational Symmetry of the Sample	48
4.3 Direction of the Scattered Waves	50
4.4 Randomly Disturbed Samples	55
4.5 Classification of Scattering Theories	56
5. Kinematical Scattering Theory	59
5.1 Scattering from a Single Atom	59
5.2 Perfect Layers	62
5.3 Refraction and Absorption Corrections	67

5.4	Deformed Samples	69
5.5	Multilayers	72
5.6	Randomly Deformed Samples	76
6.	Dynamical Scattering Theory	81
6.1	The Wave Equation	81
6.2	Boundary Conditions	83
6.3	X-Ray Reflection	86
6.4	Two-Beam Diffraction	89
6.5	Layered Samples	94
6.5.1	Multilayers: X-Ray Reflection	97
6.5.2	Multilayers: Conventional X-Ray Diffraction	99
6.6	The Takagi-Taupin Equation	100
6.7	The Kinematical Limit of the Takagi-Taupin Equation	102
6.8	The Takagi-Taupin Equation in the One-Beam Case	105
6.9	Distorted-Wave Born Approximation (DWBA)	106
References: Part II		113

Part III. Solution of Selected Experimental Problems

7.	Layer Thicknesses of Single Layers and Multilayers	119
7.1	X-Ray Reflection by Single Layers	120
7.2	X-Ray Reflection by Periodic Multilayers	128
7.3	Coplanar X-Ray Diffraction by Single Layers	134
7.4	Coplanar X-Ray Diffraction by Periodic Superlattices	137
7.5	X-Ray Grazing-Incidence Diffraction	143
7.6	Buried Layers	145
7.6.1	High-Resolution X-Ray Diffraction	145
7.6.2	X-Ray Reflection	148
7.6.3	Grazing-Incidence Diffraction	149
8.	Lattice Parameters and Lattice Strains in Single Epitaxial Layers	151
8.1	Conventional Coplanar Diffraction	151
8.2	Coplanar Extremely Asymmetric Diffraction	160
8.3	Grazing-Incidence Diffraction	164
9.	Volume Defects in Layers	169
9.1	Diffuse Scattering from Weak Defects	170
9.2	Diffuse X-Ray Reflection from Layers Containing Small-Volume Defects	180
9.3	Diffraction from Relaxed Epitaxial Layers	182

10. X-Ray Reflection by Rough Multilayers	191
10.1 Introduction	191
10.2 Interface Roughness: The Scattering Potential and its Statistical Properties	192
10.2.1 The Scattering Potential of a Multilayer with Rough Interfaces	192
10.3 Specular X-Ray Reflection	195
10.3.1 Theoretical Description	195
10.3.2 Examples	198
10.4 Non-Specular X-Ray Reflection	207
10.4.1 Theoretical Description	208
10.4.2 Examples	211
11. X-Ray Scattering by Gratings and Dots	221
11.1 Scattering by Surface Gratings: General Considerations	221
11.1.1 Scattering Potential	221
11.1.2 Diffraction by a Surface Grating	224
11.2 Coplanar X-Ray Diffraction	225
11.2.1 Determination of the Grating Period and the Etching Depth	225
11.2.2 Reciprocal-Space Mapping	226
11.2.3 Diffraction by Superlattice Surface Gratings	231
11.3 Grazing-Incidence Diffraction	232
11.3.1 Investigation of the Shape and Strain	232
11.4 Diffraction by Buried Gratings	236
11.5 Lateral Strain-Induced Patterning	238
11.6 Quantum Dots	240
References: Part III	243
A. Wave Vectors and Amplitudes of the Internal Wavefields in a Dynamically Scattering Crystal	247
A.1 Coplanar Diffraction	247
A.2 Grazing-Incidence Diffraction	250
A.3 X-Ray Reflection	251
Index	253